FAIRCHILD

SEMICONDUCTOR

74F114 Dual JK Negative Edge-Triggered Flip-Flop with Common Clocks and Clears

General Description

The 74F114 contains two high-speed JK flip-flops with common Clock and Clear inputs. Synchronous state changes are initiated by the falling edge of the clock. Triggering occurs at a voltage level of the clock and is not directly related to the transition time. The J and K inputs can change when the clock is in either state without affecting the flip-flop, provided that they are in the desired state during the recommended setup and hold times relative to the falling edge of the clock. A LOW signal on \overline{S}_D or \overline{C}_D prevents clocking and forces Q or \overline{Q} HIGH, respectively.

Simultaneous LOW signals on \overline{S}_D and \overline{C}_D force both Q and \overline{Q} HIGH.

Asynchronous Inputs:

LOW input to \overline{S}_D sets Q to HIGH level LOW input to \overline{C}_D sets Q to LOW level

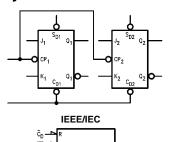
Clear and Set are independent of Clock Simultaneous LOW on \overline{C}_D and \overline{S}_D

makes both Q and \overline{Q} HIGH

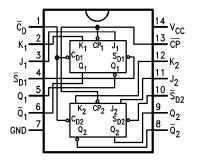
Ordering Code:

Order Number	Package Number	Package Description
74F114SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74F114PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
Devices also available	in Tane and Real Specify	by appending the suffix letter "X" to the ordering code

Logic Symbols







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74F114

Unit Loading/Fan Out

Pin Names		U.L.	Input I _{IH} /I _{IL}	
	Description	HIGH/LOW	Output I _{OH} /I _{OL}	
J ₁ , J ₂ , K ₁ , K ₂	Data Inputs	1.0/1.0	20 µA/-0.6 mA	
CP	Clock Pulse Input (Active Falling Edge)	1.0/8.0	20 µA/–4.8 mA	
CD	Direct Clear Input (Active LOW)	1.0/10.0	20 µA/–6.0 mA	
S _{D1} , S _{D2}	Direct Set Inputs (Active LOW)	1.0/5.0	20 µA/-3.0 mA	
$Q_1, Q_2, \overline{Q}_1, \overline{Q}_2$	Outputs	50/33.3	–1 mA/20 mA	

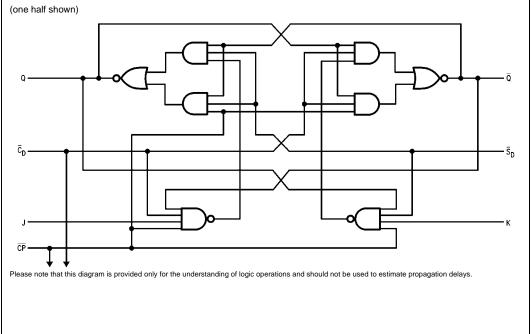
Truth Table

		Outputs				
SD	CD	СР	J	к	q	Q
L	Н	Х	Х	Х	Н	L
н	L	Х	Х	Х	L	н
L	L	Х	Х	Х	н	н
н	н	~	h	h	\overline{Q}_0	Q_0
н	н	~	I	h	L	н
н	н	~	h	I	н	L
н	Н	\sim	I	I	Q_0	\overline{Q}_0

H (h) = HIGH Voltage Level L (h) = LOW Voltage Level X = Immaterial

Lower case letters indicate the state of the referenced input or output one setup time prior to the HIGH-to-LOW clock transition.

Logic Diagram



Absolute Maximum Ratings(Note 1)

Storage Temperature Ambient Temperature under Bias Junction Temperature under Bias V_{CC} Pin Potential to Ground Pin Input Voltage (Note 2) Input Current (Note 2) Voltage Applied to Output in HIGH State (with $V_{CC} = 0V$) Standard Output 3-STATE Output Current Applied to Output in LOW State (Max) twice the rated I_{OL} (mA)

-65°C to +150°C $-55^{\circ}C$ to $+125^{\circ}C$ $-55^{\circ}C$ to $+150^{\circ}C$ -0.5V to +7.0V -0.5V to +7.0V -30 mA to +5.0 mA

-0.5V to V_{CC}

-0.5V to +5.5V

Recommended Operating Conditions

Free Air Ambient Temperature Supply Voltage

 $0^{\circ}C$ to $+70^{\circ}C$ +4.5V to +5.5V 74F114

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Symbol	Parameter		Min	Тур	Max	Units	V _{cc}	Conditions	
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
VIL	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	I _{IN} = -18 mA	
V _{OH}	Output HIGH	10% V _{CC}	2.5			V	Min	I _{OH} = -1 mA	
	Voltage	5% V _{CC}	2.7					$I_{OH} = -1 \text{ mA}$	
V _{OL}	Output LOW	10% V _{CC}			0.5	V	Min	I _{OL} = 20 mA	
	Voltage								
I _{IH}	Input HIGH				5.0			V 0.7V	
	Current				5.0	μA	Max	$V_{IN} = 2.7V$	
I _{BVI}	Input HIGH Current				7.0			V 70V	
	Breakdown Test				7.0	μA	Max	V _{IN} = 7.0V	
ICEX	Output High				50	μA	Max	$V_{OUT} = V_{CC}$	
	Leakage Current				50	μΑ	IVIAX	V _{OUT} = V _{CC}	
V _{ID}	Input Leakage		4.75			V	0.0	I _{ID} = 1.9 μA	
	Test		4.75			v	0.0	All Other Pins Grounded	
I _{OD}	Output Leakage				3.75	μA	0.0	V _{IOD} = 150 mV	
	Circuit Current				3.75	μΑ	0.0	All Other Pins Grounded	
IIL	Input LOW Current				-0.6			$V_{IN} = 0.5V (J_n, K_n)$	
					-3.0			$V_{IN} = 0.5V \ (\overline{S}_{Dn})$	
					-4.8	mA	Max	$V_{IN} = 0.5V (C\overline{P})$	
					-6.0			$V_{IN} = 0.5V \ (\overline{C}_{Dn})$	
los	Output Short-Circuit Current		-60		-150	mA	Max	$V_{OUT} = 0V$	
I _{CCH}	Power Supply Current			12.0	19.0	mA	Max	V _O = HIGH	
I _{CCL}	Power Supply Current			12.0	19.0	mA	Max	$V_{O} = LOW$	

DC Electrical Characteristics

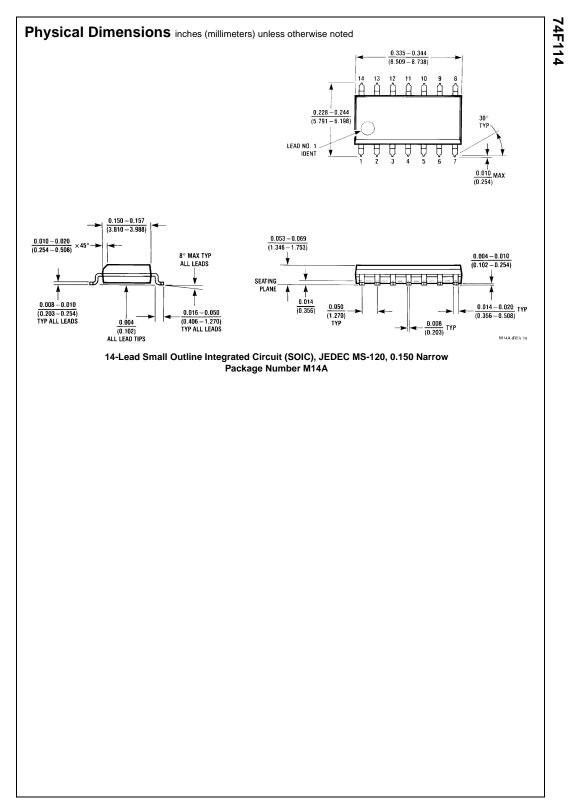
74F114

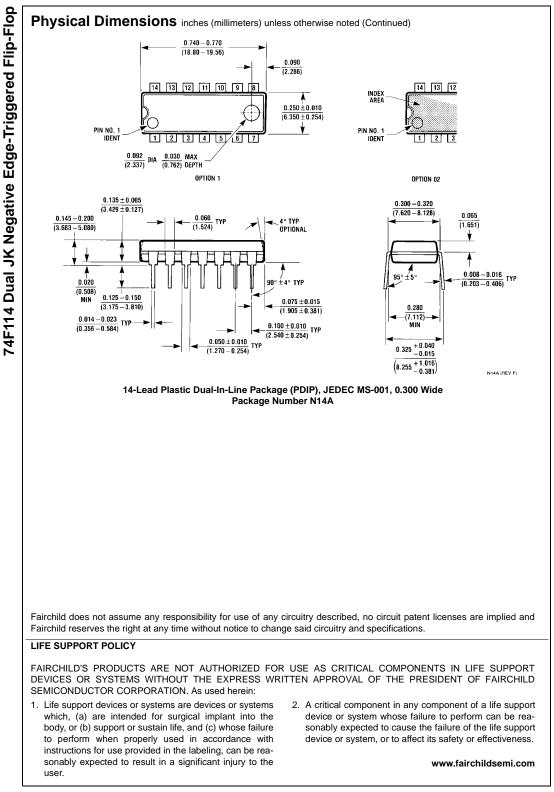
AC Electrical Characteristics

Symbol	Parameter		$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$T_{A} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		
		Min	Тур	Max	Min	Max		
f _{MAX}	Maximum Clock Frequency	75	95		70		MHz	
t _{PLH}	Propagation Delay	3.0	5.0	6.5	3.0	7.5		
t _{PHL}	\overline{CP} to Q_n or \overline{Q}_n	3.0	5.5	7.5	3.0	8.5	ns	
t _{PLH}	Propagation Delay	3.0	4.5	6.5	3.0	7.5		
t _{PHL}	\overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	3.0	4.5	6.5	3.0	7.5	ns	

AC Operating Requirements

Symbol	Parameter		$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$		$T_A = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$		
		Min	Max	Min	Max	1	
t _S (H)	Setup Time, HIGH or LOW	4.0		5.0			
t _S (L)	J _n or K _n to CP	3.0		3.5			
t _H (H)	Hold Time, HIGH or LOW	0		0		ns	
t _H (L)	J _n or K _n to CP	0		0			
t _W (H)	CP Pulse Width	4.5		5.0		ns	
t _W (L)	HIGH or LOW	4.5		5.0		115	
t _W (L)	\overline{C}_{Dn} or \overline{S}_{Dn} Pulse Width,	4.5		5.0		ns	
	LOW						
t _{REC}	Recovery Time	4.0		5.0		ns	
	S _{Dn} , C _{Dn} , to CP						





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6

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